



RLS Trade-Off: Questions about Molecular Size and Quantum Yield

Robert Brainard and Craig Higgins



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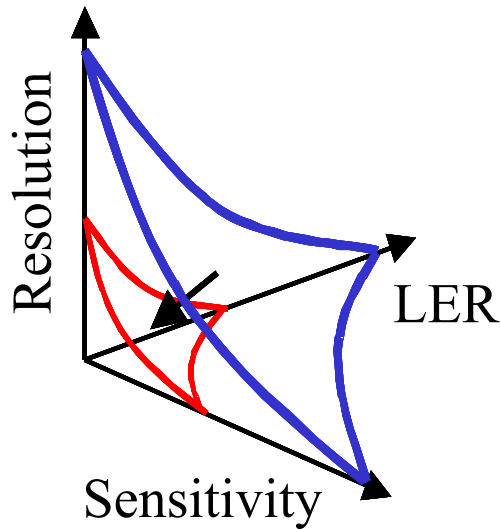
Outline

- I. Introduction**
- II. Effect of Molecular Weight**
- III. Quantum Yield**
- IV. Ultra High PAG Resists**
- V. Conclusions and Questions**

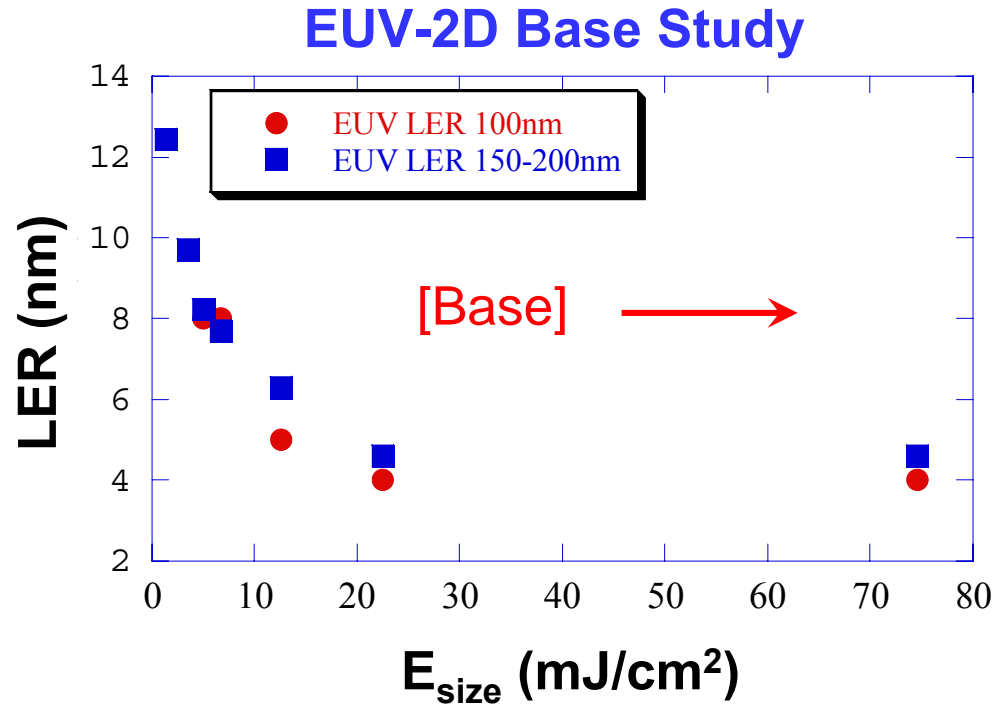
RLS Trade-Off¹

New materials/approaches are needed to “break-through” to new performance surfaces:

- Reduction in Polymer Molecular Weight
- Increasing Quantum Yield

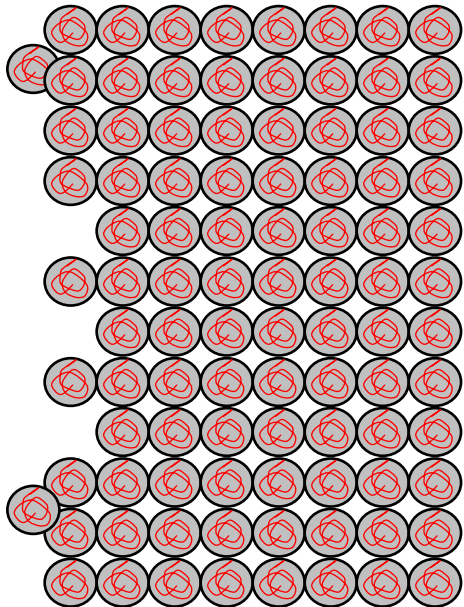


Surfaces defined by
Z-Parameter or K_{LUP}



II. Effect of Molecular Weight

Can we reduce LER by decreasing the size of the polymer?



In this conference:
61% of the papers
about new resist materials
are about **Molecular Glasses**

Polymer Radius of Gyration

$$R_g = 3-4 \text{ nm}$$

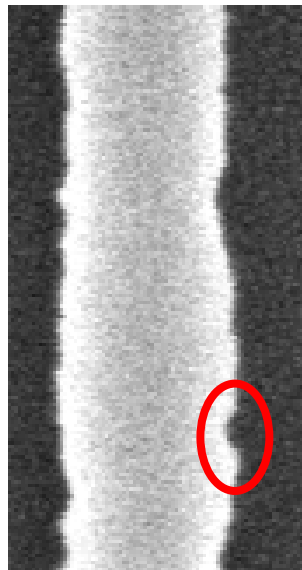
$$\text{Diameter} = 6-8 \text{ nm}$$

II. Effect of Polymer M_w on LER: EUV-2D using 0.088 NA in 2003²

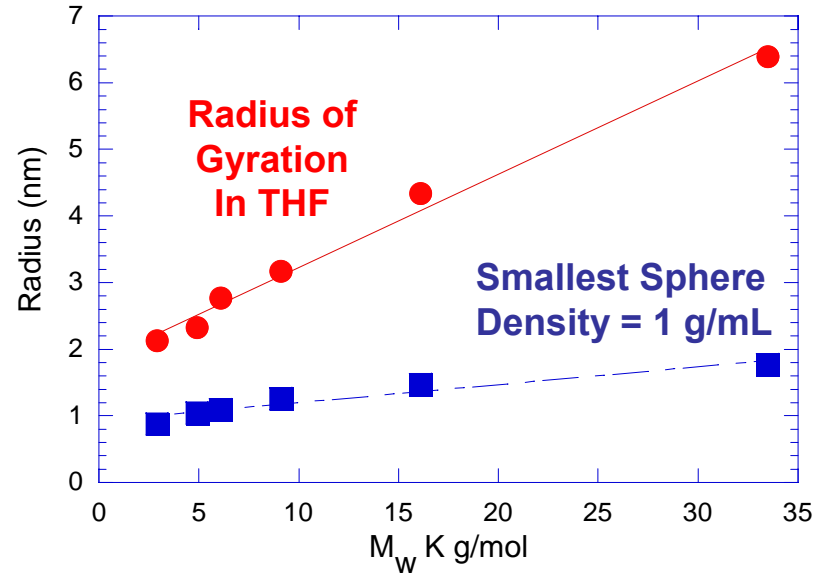
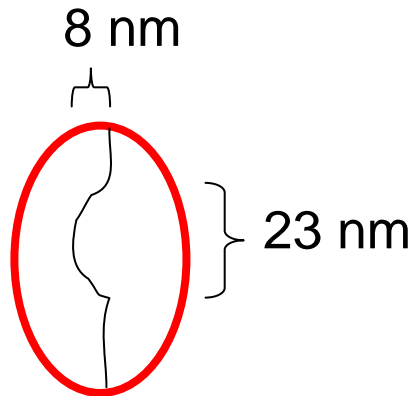
6 New Polymers $M_w = 3-33$ Kg/mol

Changes in M_w will alter
dissolution properties:

Vary [PAG] and [base]



100 nm Line
8 nm 3- σ LER



$R_g = 2-6$ nm
Diameter = 4-12 nm



$R = 0.9-1.8$ nm
Diameter = 1.8-3.6 nm

[PAG] and [Base] Variations over Wide Polymer M_w Range

Round 1

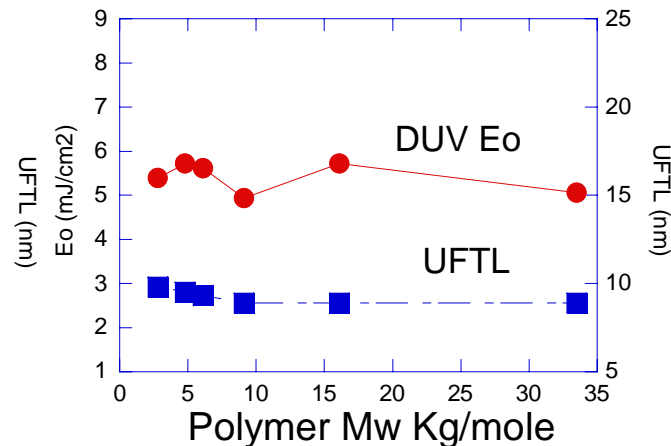
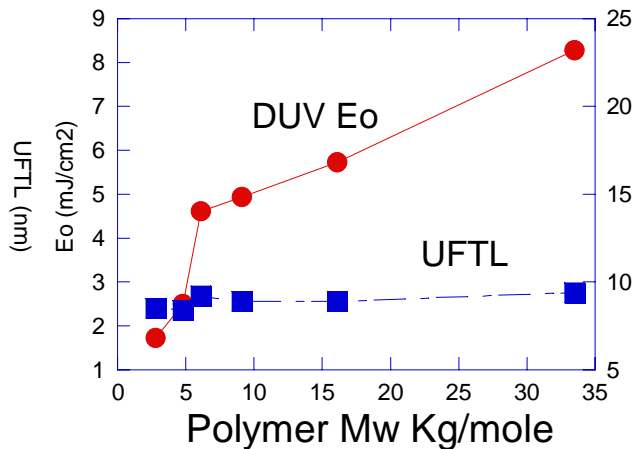
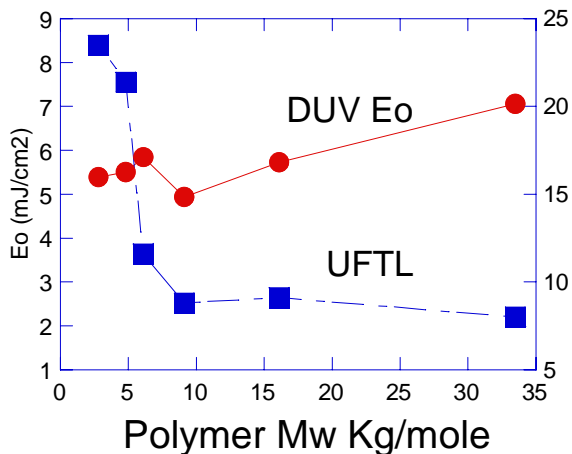
6 Mws
Changing UFTLs

Round 2

6 Mws, 6 [PAG]
Constant UFTL
Changing E_o

Round 3

6 Mws
6 [PAG], 6 [Base]
Constant UFTL, E_o

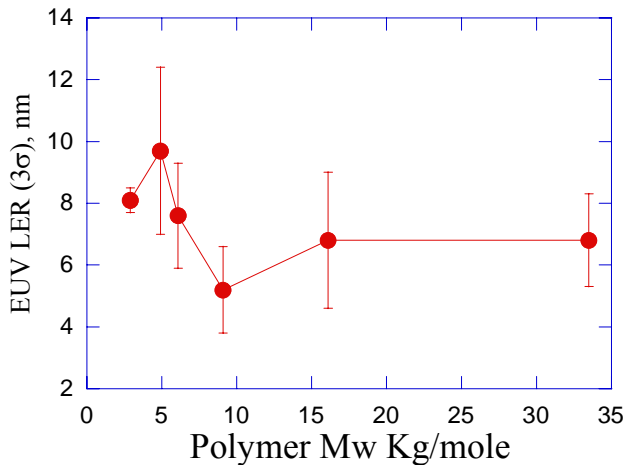


**UFTL =
Unexposed Film Thickness Loss or Dark Loss**

M_w has no effect on LER

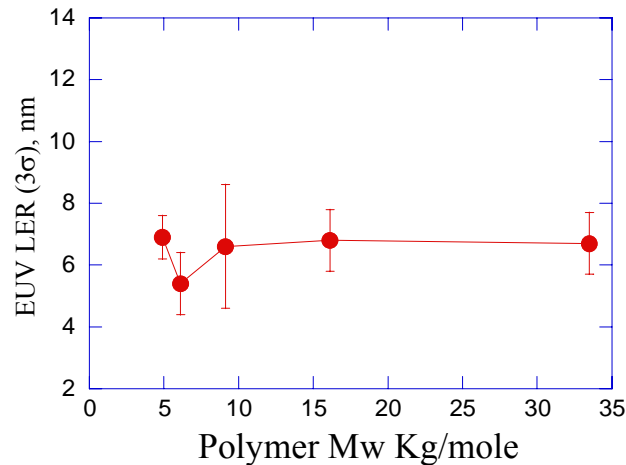
Round 1

6 Mws
Changing UFTLs



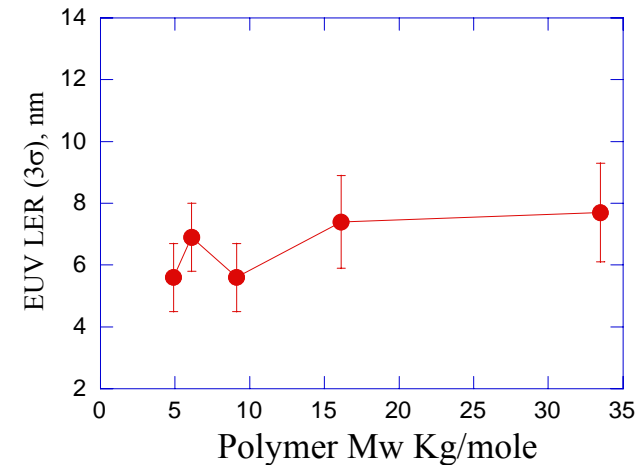
Round 2

6 Mws, 6 [PAG]
Constant UFTL
Changing E_o



Round 3

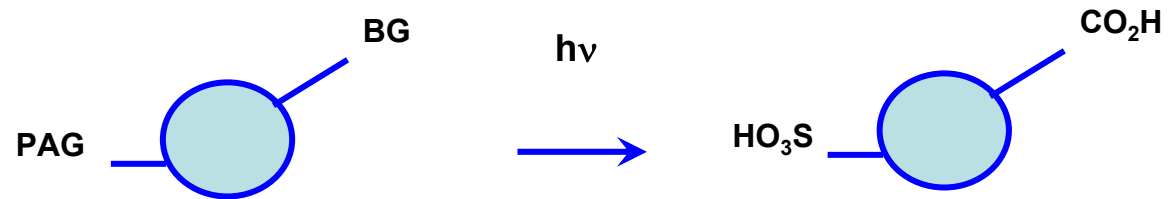
6 Mws
6 [PAG], 6 [Base]
Constant UFTL, E_o



LER is **UNAFFECTED** by an order of magnitude change in polymer M_w when UFTL is held constant.

II. Molecular Glasses (MG)

Start Small
Stay Small



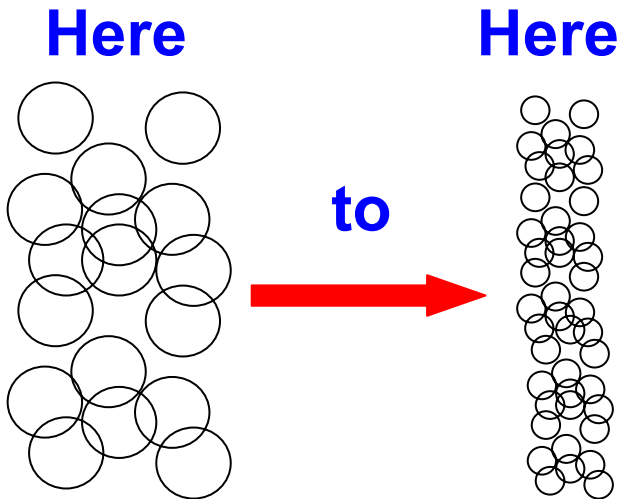
- 1) (My observation) Positive Molecular Glasses **DO NOT** show improved LER, unless they are fairly slow.
- 2) Negative resists look good → Because of polymer formation?
- 3) Champion resists appear to result from polymeric resists.

Questions about the role of Molecular Size:

- (1) Our polymer Mw work was performed in 2003 at 0.088 NA. Should it be repeated at 0.3 NA and/or IL?
- (2) Should Molecular Glass Resists be included in a systematic study against polymeric resists?
- 3) Why do negative MG resists appear to give good LER/Sensitivity? Must polymers be involved for top performance?

III. Can we Beat RLS by Increasing Film Quantum Yield?

We propose that higher quantum yield will allow us to go from...



...with no penalty to sensitivity.

Gregg Gallatin:³

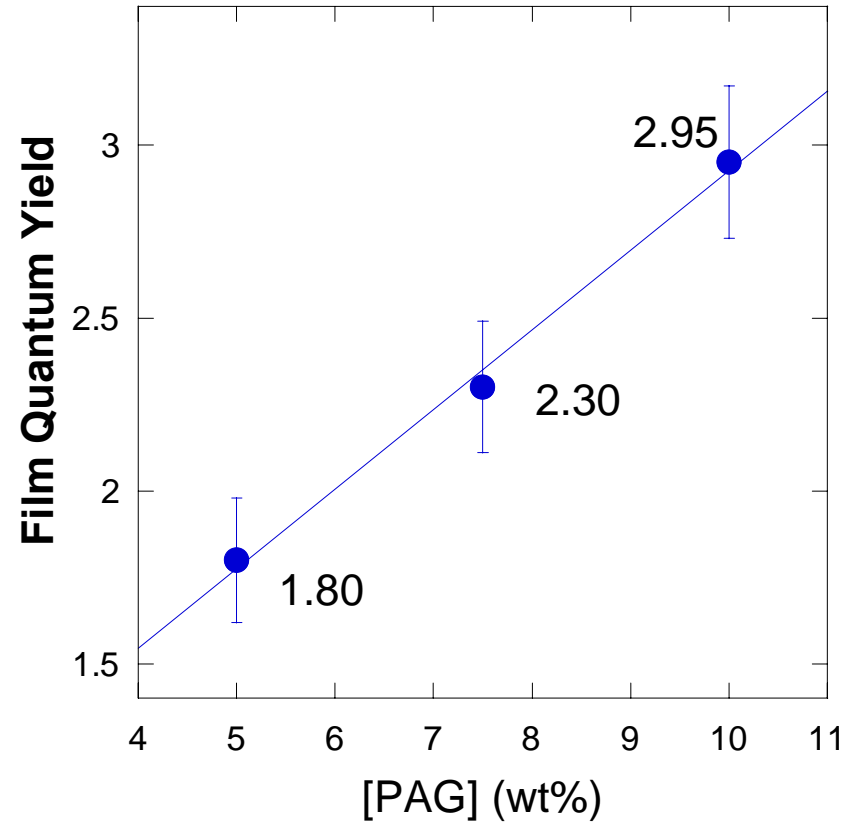
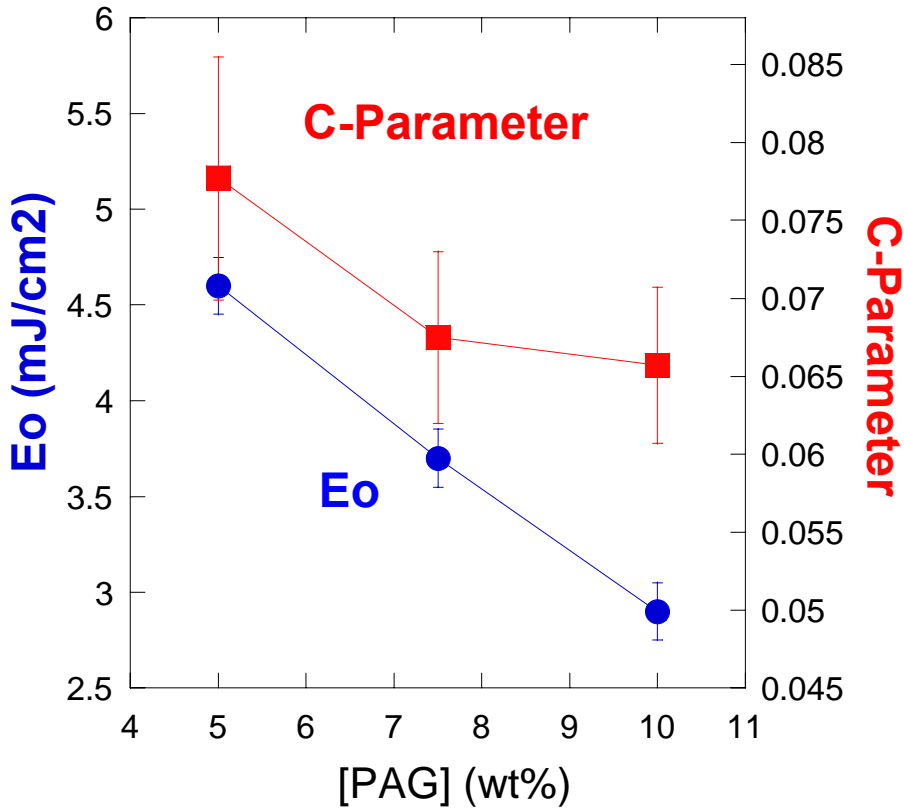
Increased quantum yield can break the RLS tradeoff

$$LER \propto \frac{1}{\sqrt{\alpha Q E R^3}}$$

**Film
Quantum
Yield**

$$= \frac{\text{Number of Acids Generated in the Film}}{\text{Number of Photons Absorbed in the Film}}$$

Quantum Yield Increases with PAG Concentration

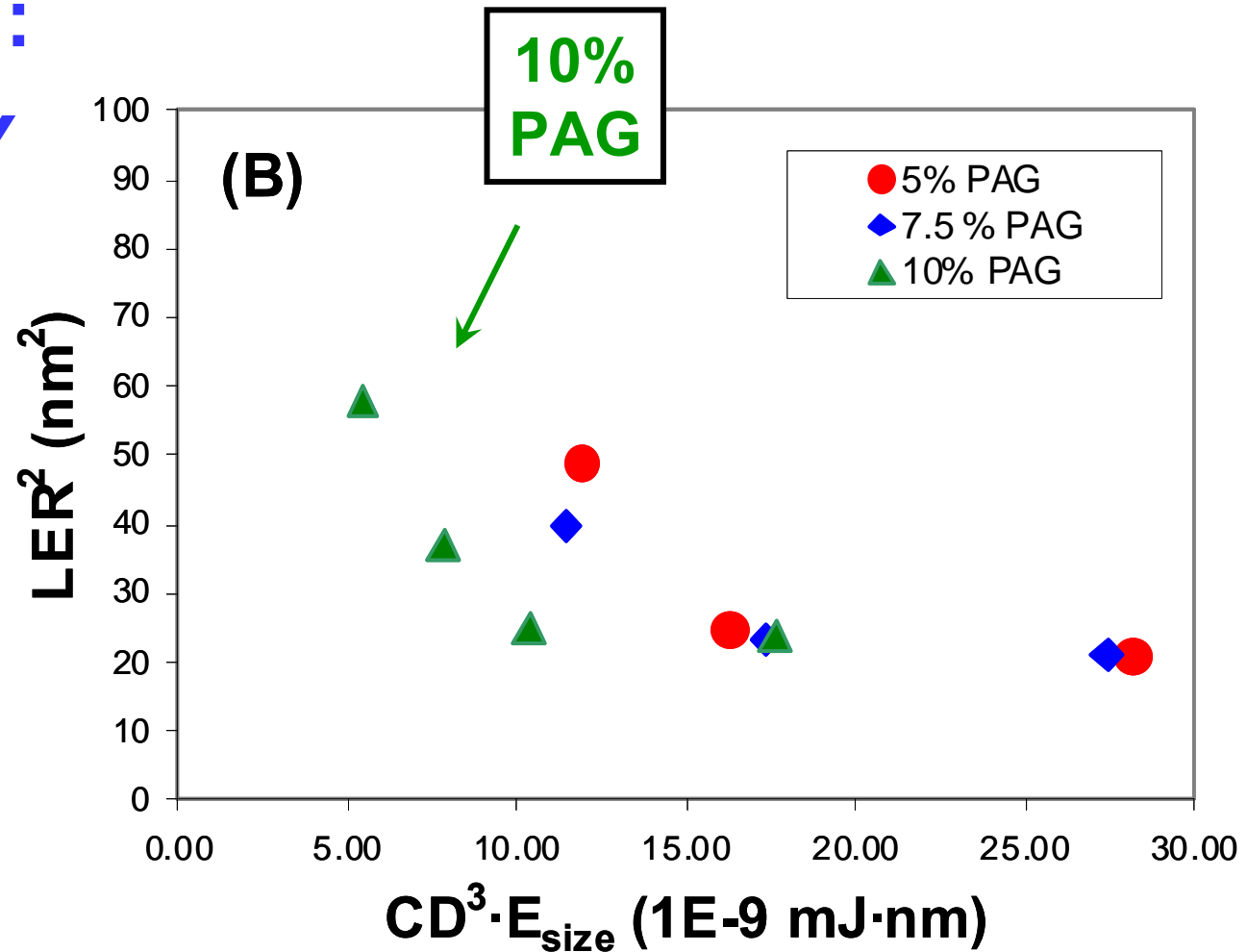


Used Szmanda
Base-Titration Method

Acids Generated = $[PAG](1 - e^{-CE})(6.02 \times 10^{23})$

Higher [PAG]:

- Higher FQY
- Lower $Z^{3,4}$



(3) Gallatin, EUV 2007 Symposium

(4) Wallow, Higgins and Brainard, SPIE 2008

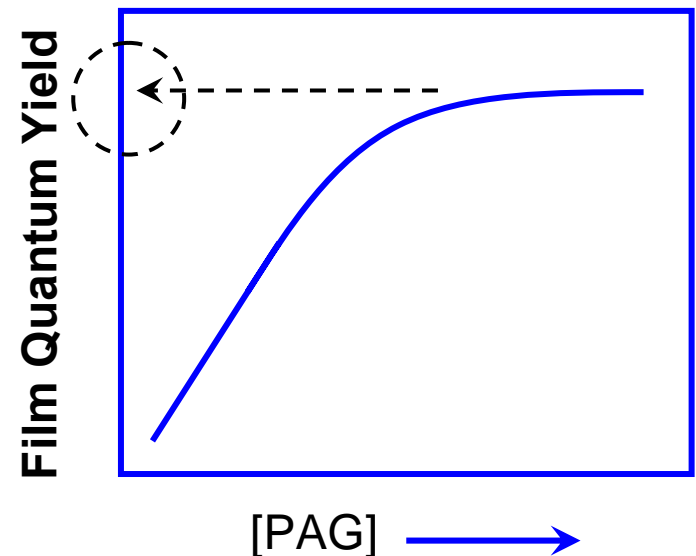
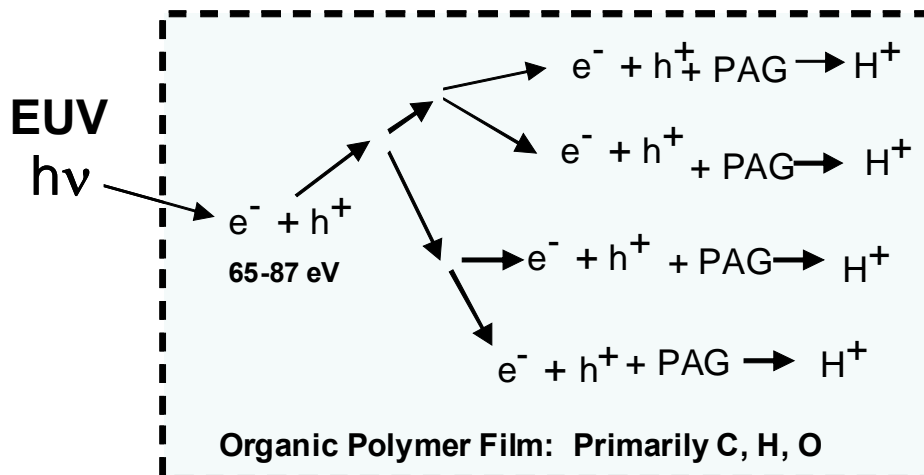
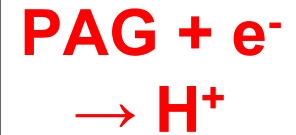
How far can we push [PAG]?

IV. Ultra High PAG Resists

Question #1: How high can we make FQY?

Question #2: Do we improve RLS?

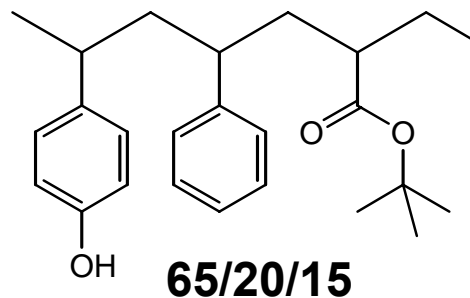
Question #3: Can we determine how many photoelectrons are made?



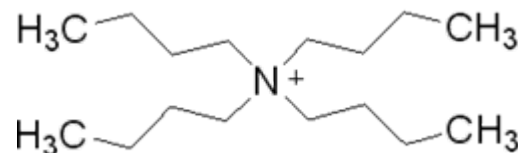
IV. High PAG Resist Platforms for FQY and Imaging RLS Study

Resist Formulations

Polymer

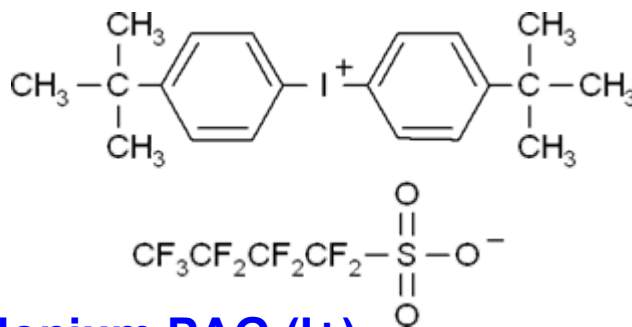


Base
TBAH

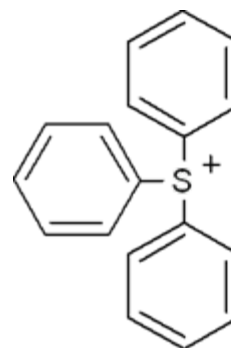


OH-

Photoacid
Generator
(PAG)



Iodonium PAG (I+)
DTBI-PFBS

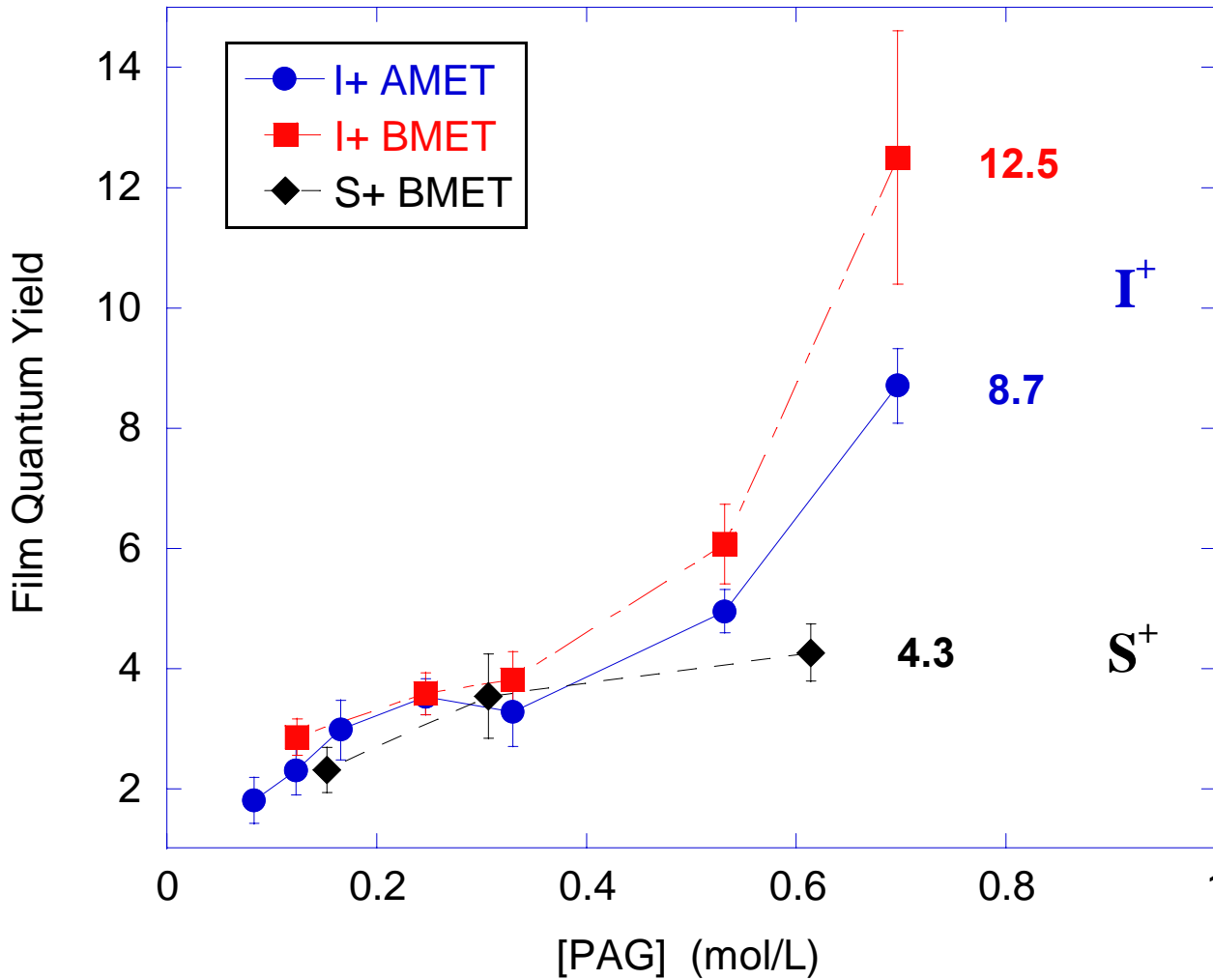


CF₃CF₂CF₂CF₂SO₃⁻

Sulfonium PAG (S+)
TPS-PFBS

(5) Hassanein, Higgins, Thackeray, Brainard et al SPIE (2008)

Film Quantum Yields vs. [PAG]



I⁺ FQY =
~10 H⁺ / EUV hν

S⁺ FQY =
~4 H⁺ / EUV hν

(6) Brainard, Higgins et al., Journal of Photopolymer Science and Tech. (2008)

Resolution of Ultra-High PAG Resists

120 nm

100 nm

80 nm

60 nm

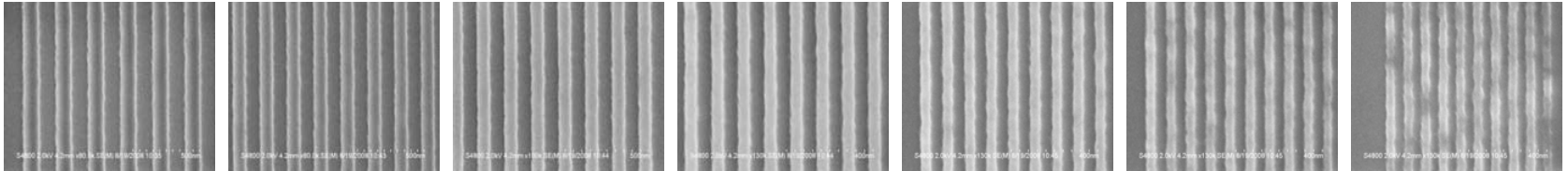
50 nm

45 nm

40 nm

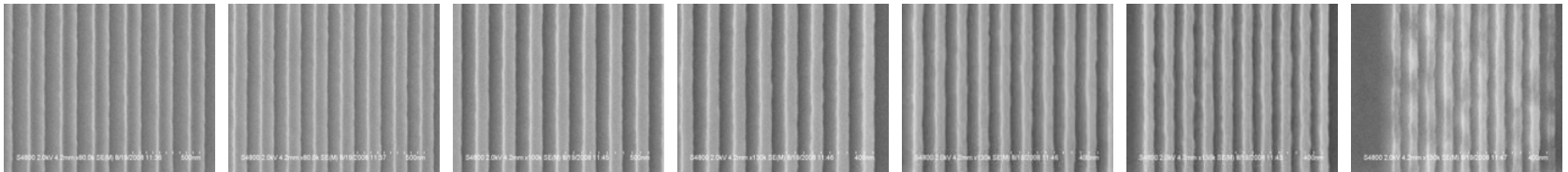
5 wt%

(0.083 mM)



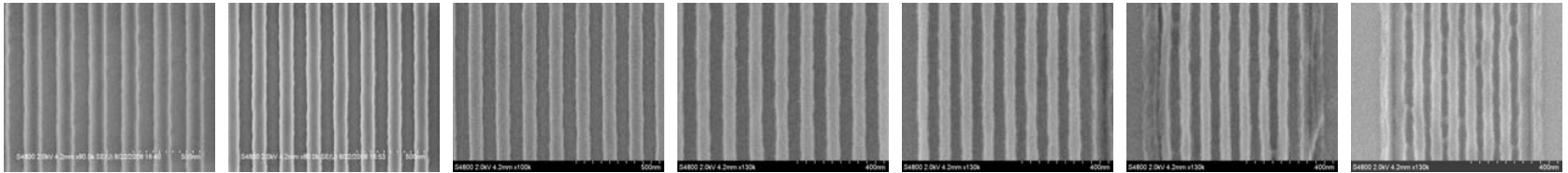
7.5 wt%

(0.123 mM)



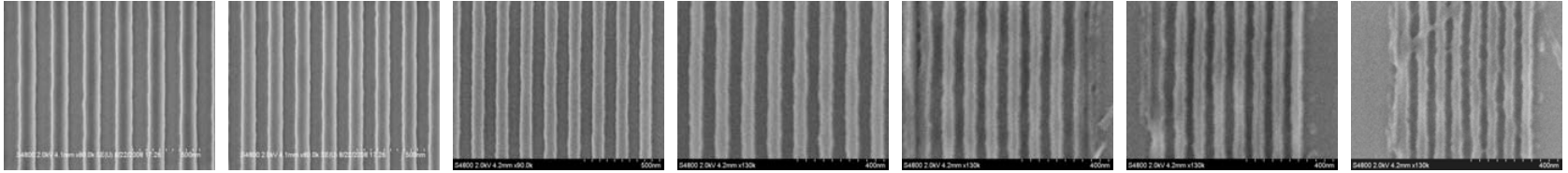
15 wt%

(0.247 mM)



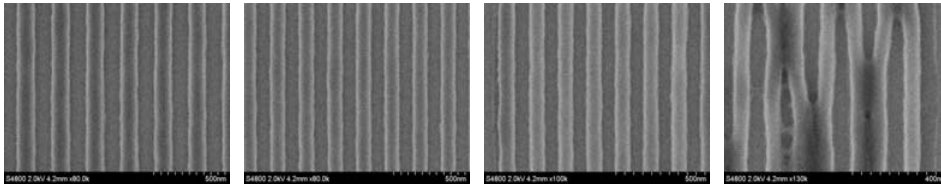
20 wt%

(0.330 mM)



30 wt%

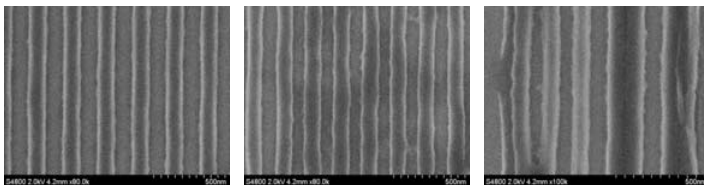
(0.532 mM)



Iodonium PAG
80 nm Film Thickness

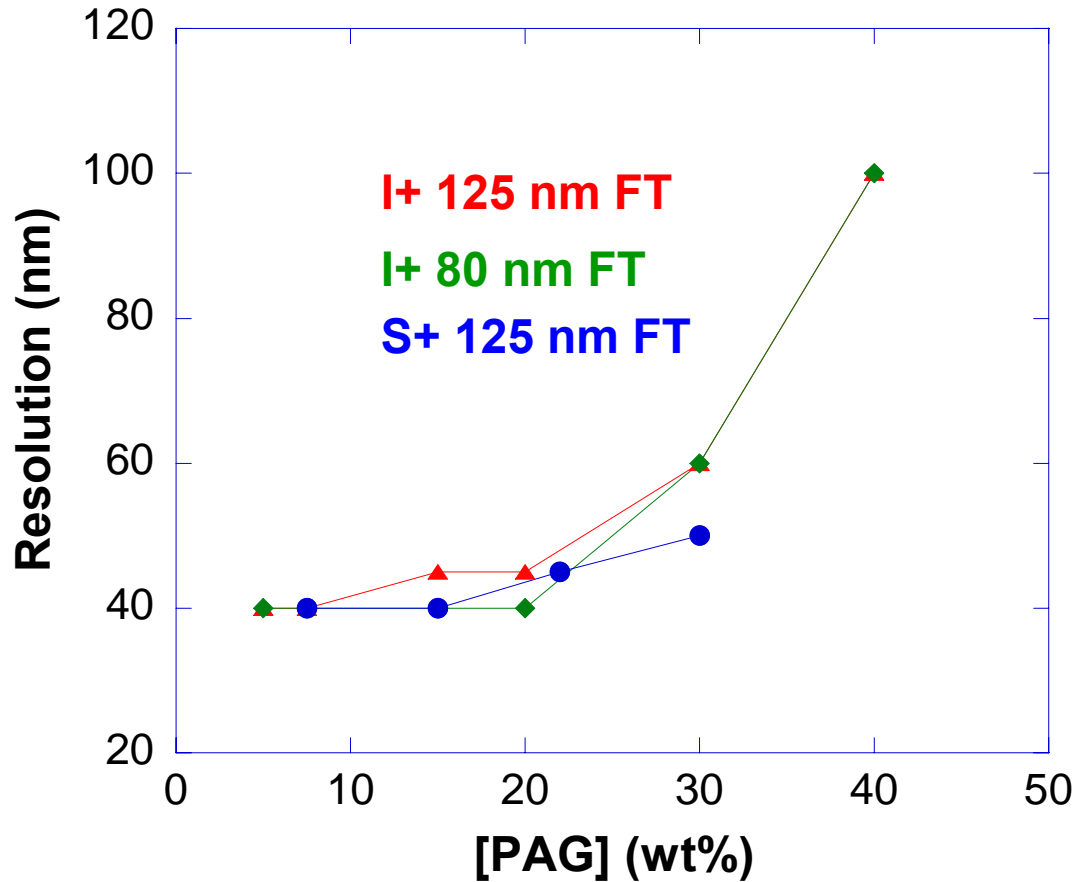
40 wt%

(0.697 mM)



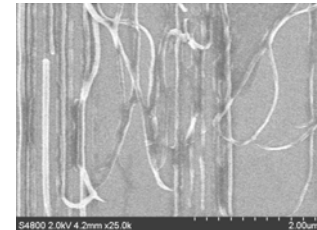
1:1 Line/Space through PAG Loading

Resolution of Ultra-High PAG Resists

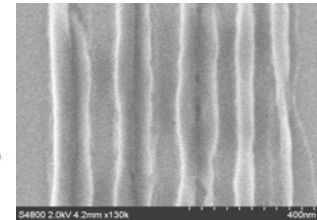


Patterning Issues at Very High PAG Loadings:

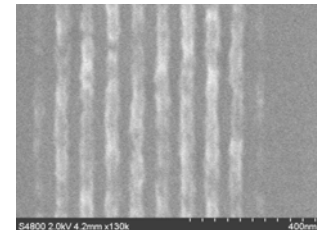
I+ 125 nm FT:
- Adhesion Failure



I+ 80 nm FT:
- Pattern Collapse

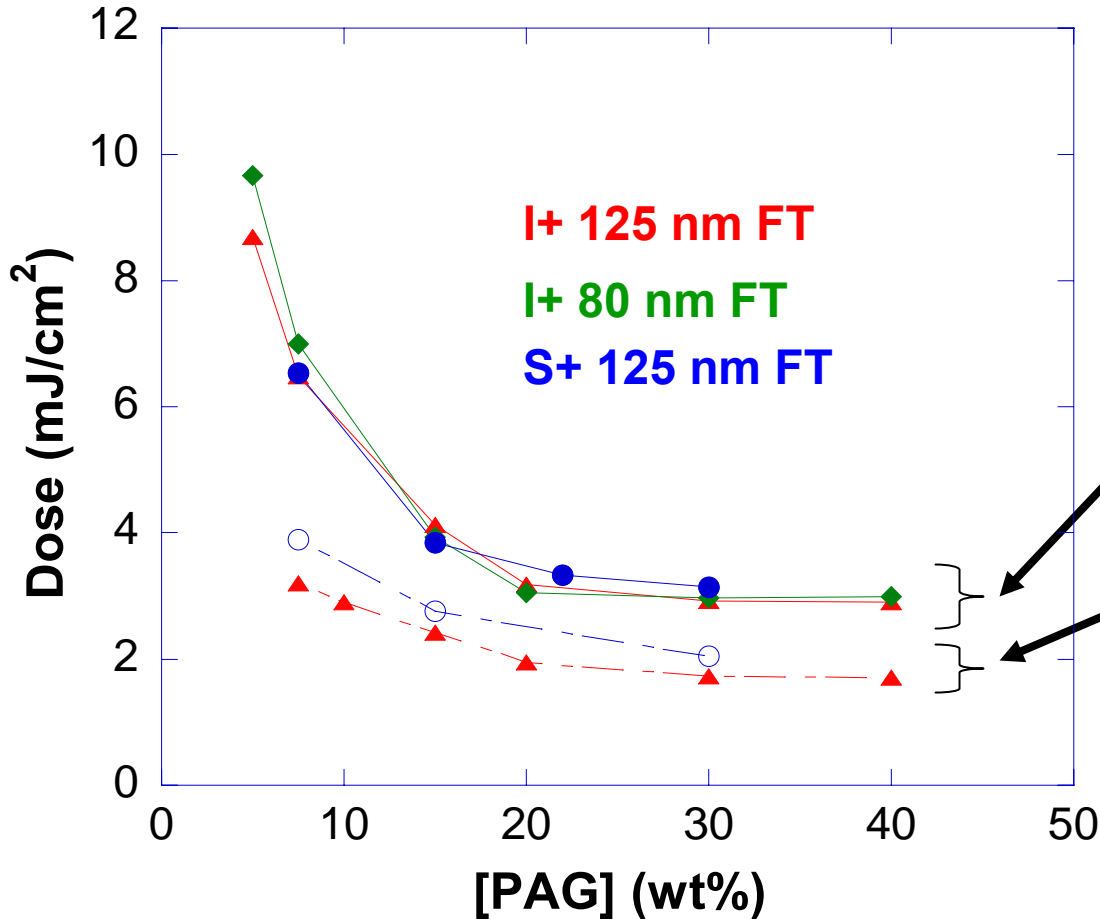


S+ 125 nm FT:
- Top Loss



Resolution is consistent, then degrades at > 20% PAG

Sensitivity of Ultra-High PAG Resists

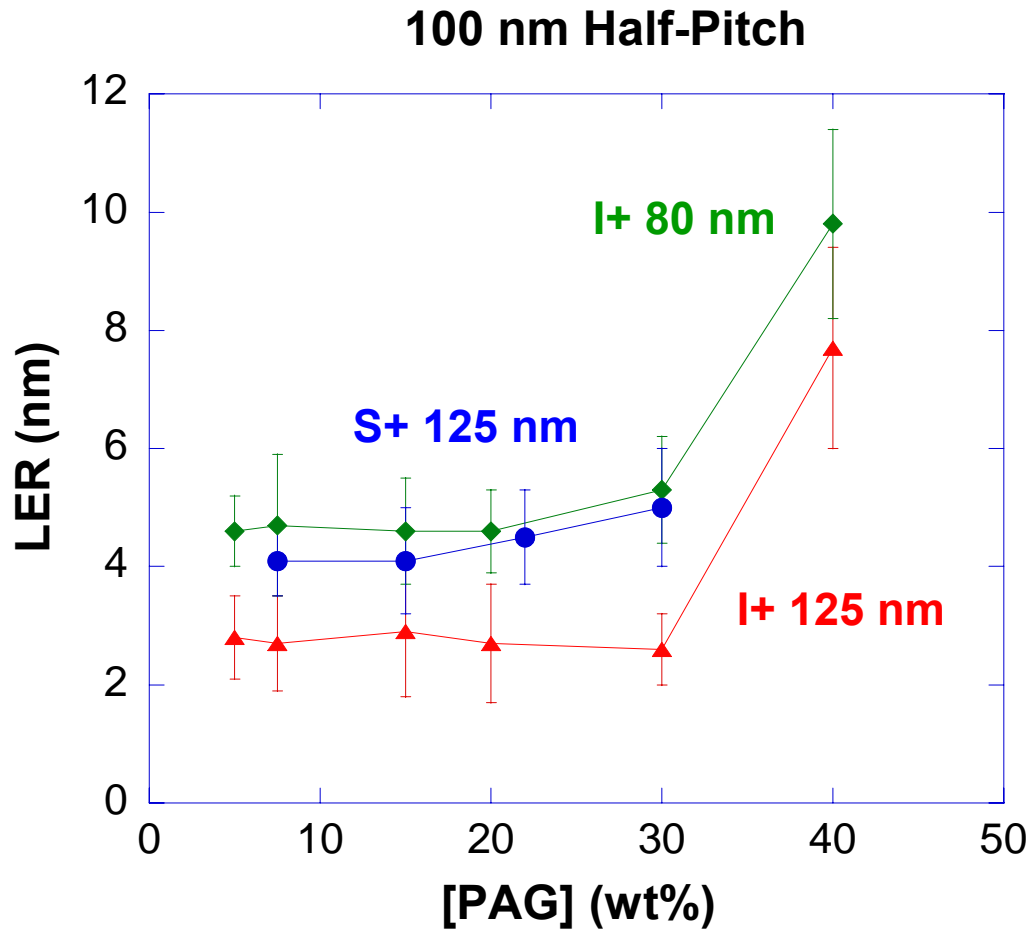


Esize (100 nm L/S) Data:
- Saturated at 15-20% PAG

Eo Data:
- Saturated at 15-20% PAG

All data obtained from BMET

LER of Ultra-High PAG Resists

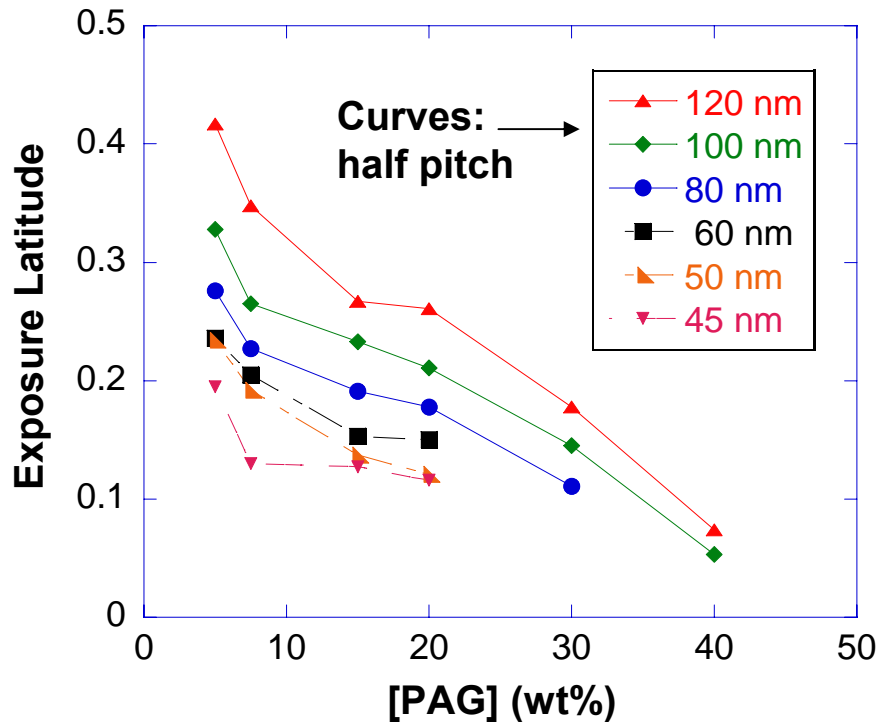


LER is consistent, then degrades > 30-40 wt% PAG

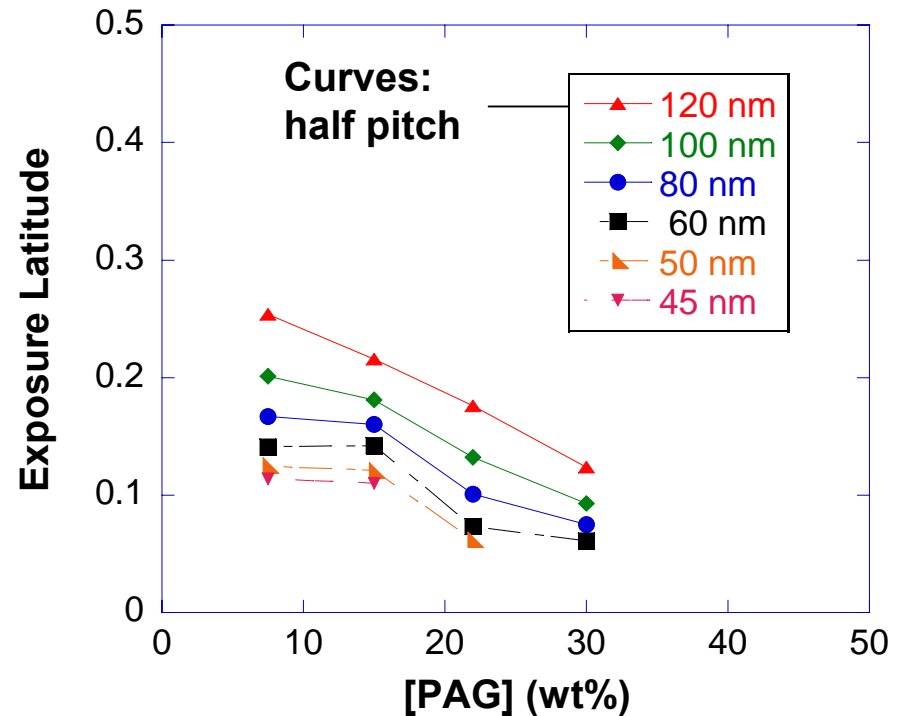
Exposure Latitude, Acid Diffusion and K_{LUP}

Exposure Latitude *decreases* with [PAG]

Iodonium PAG

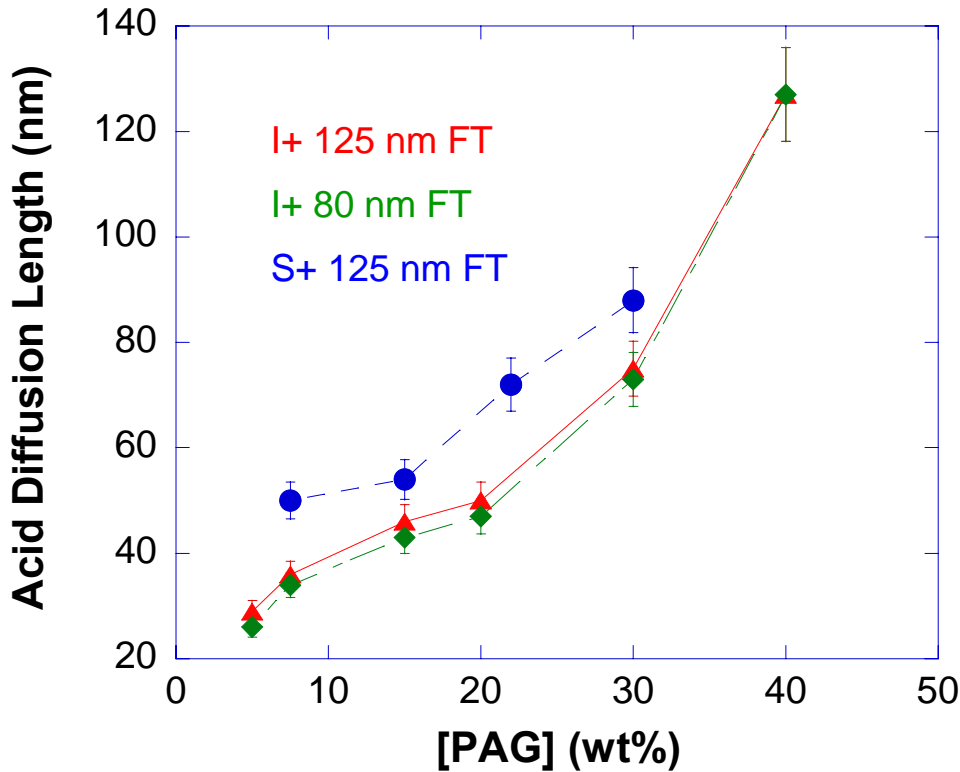


Sulfonium PAG



All Data at 125 nm Film Thickness

Acid Diffusion *Increases* with [PAG]



Acid diffusion was determined from exposure latitude using the following method:⁷

$$MTF_{DIFF} \propto \frac{EL}{NILS}$$

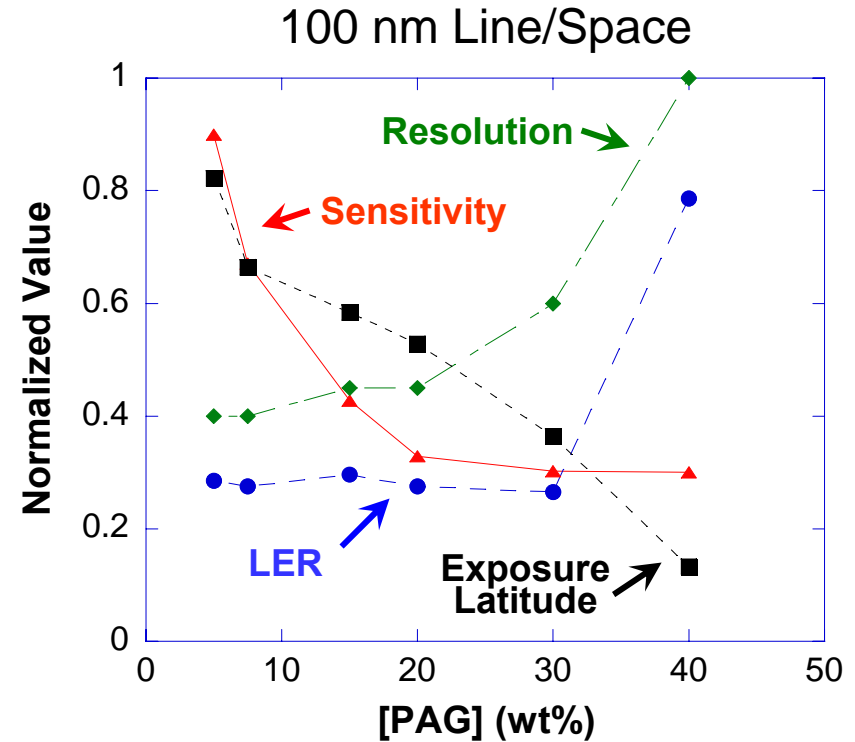
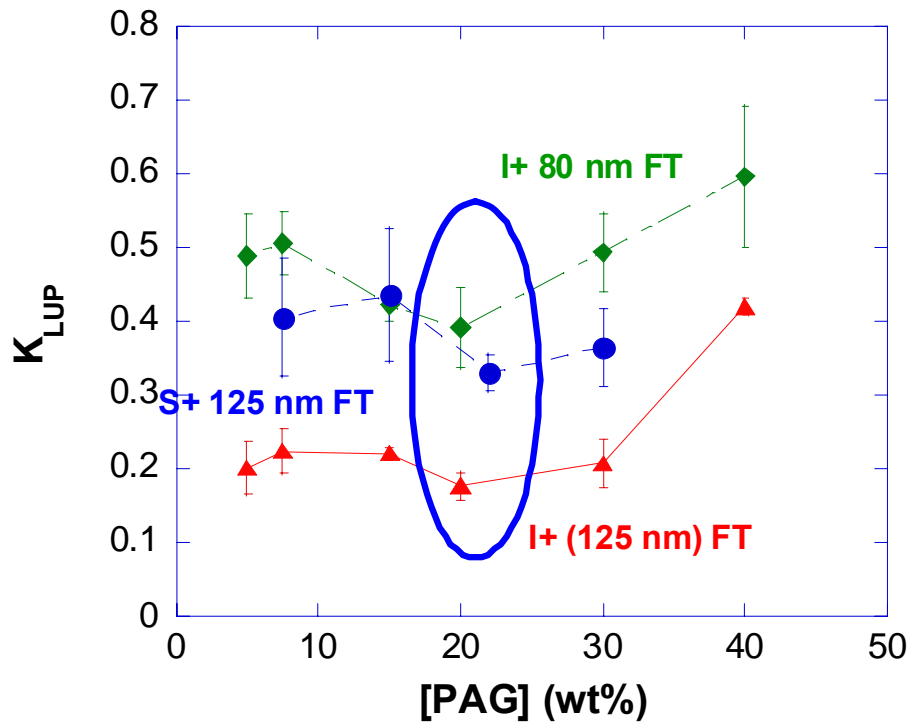
$$MTF_{diff} = \frac{1 - \exp\left(-2\pi^2\left(\frac{L_D}{p}\right)^2\right)}{2\pi^2\left(\frac{L_D}{p}\right)^2}$$

Why does L_D increase for increasing PAG?

(7) Van Steenwinckel, Lammers, Koehler, Brainard, and Trefonas JVST (2005)

Ultra-High PAG Resist Performance:

K_{LUP}



Best performance is at ~20% PAG:

Sensitivity Gains are Cancelled by Acid Diffusion Increases

V. Conclusions and Additional Questions

LER and Resolution Appear to be Flat with [PAG],
but then degrades at $> 30\%$ PAG.

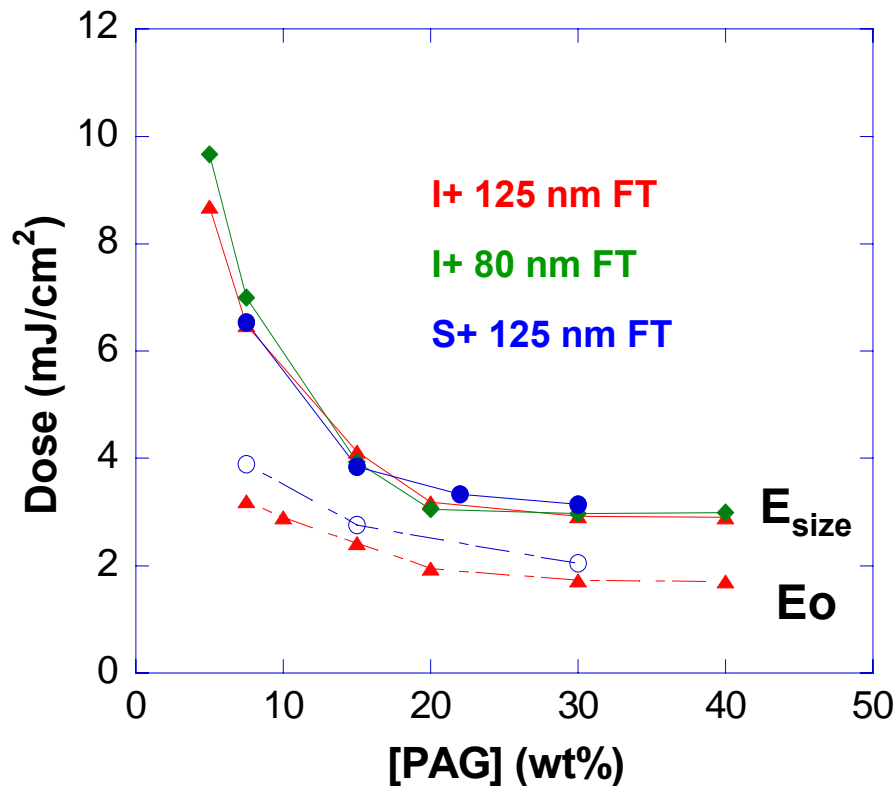
Sensitivity improves, but then flattens out.

EL decreases/ diffusion increases with [PAG]

The KLUP analysis shows that the sensitivity gains
are cancelled by the increased diffusion.

**Why do the improvements in
sensitivity stop?**

Why do the improvements in sensitivity stop?



a) Base is being overwhelmed

b) Used all available electrons (but why the high FQY for I+?)

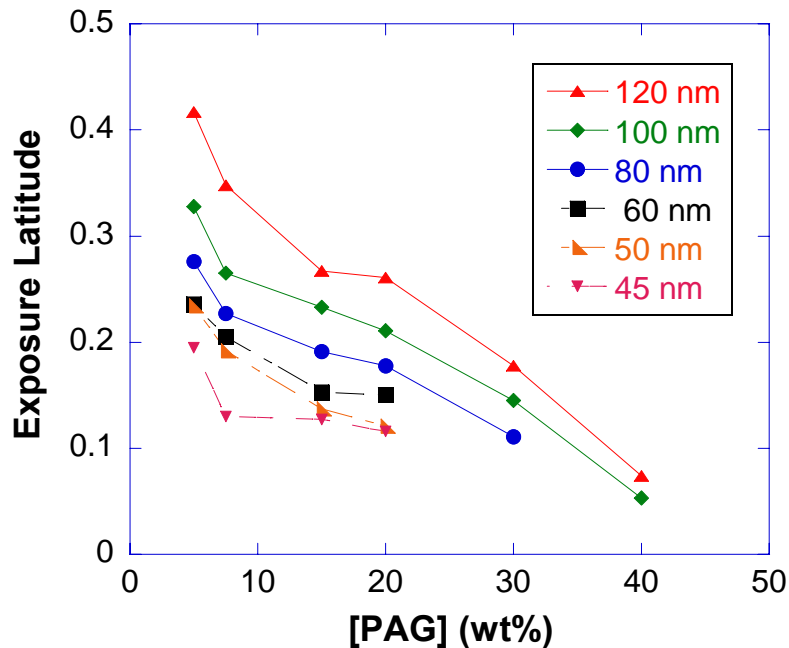
c) Not enough deblocking groups

**Why does diffusion increase
with [PAG]?**

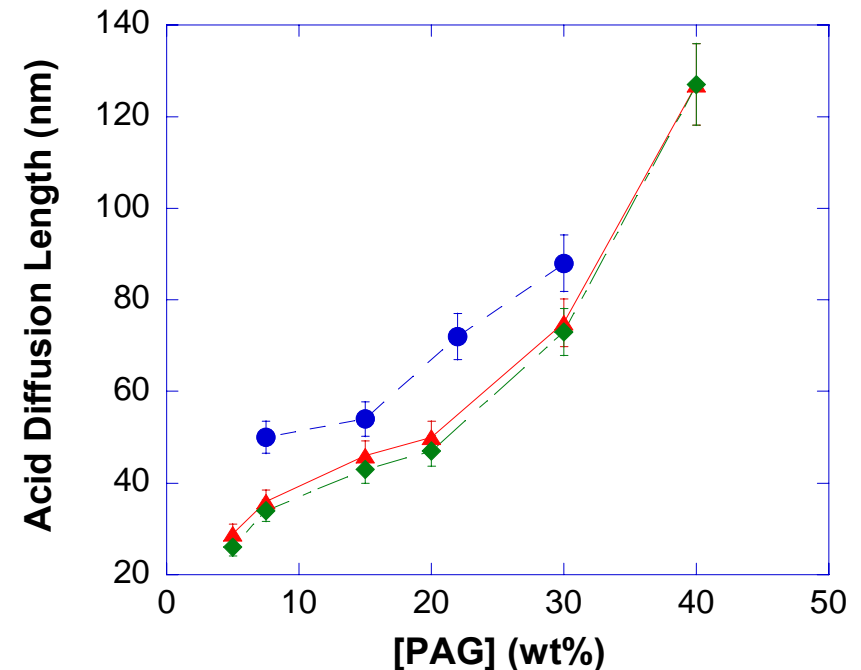
Why does diffusion increase with [PAG]?

- a) Film T_g may change
- b) Acid solubility parameter may change
- c) More free volume for acid to diffuse
- d) Base is being overwhelmed

Exposure Latitude



Acid Diffusion



V. Planned and Possible Future Work

1) Verify Film Quantum Yield Results

(SEMATECH Funded – In Collaboration with G. Denbeaux)

- a) Use direct method for determining optical density
- b) Use acid sensitive dye to directly measure acid generation

2) Test Low Diffusion Material and Processes

a) Lower PEB temperature

Increased generated acids no longer need to diffuse as far

b) Increase TBA deblocking group in polymer

[TBA] may be limiting deblocking rate in high [PAG]

Optimize surface for better adhesion

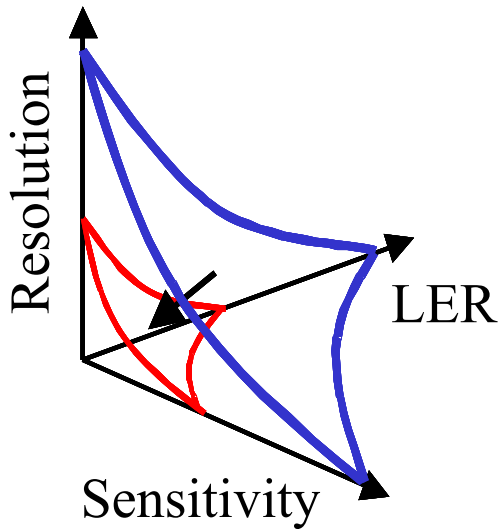
**Will Smaller Molecules give
better LER?**

V. Possible Future Work

3) Side-by-side comparison of polymeric and MG resists using:

- 10 X range in Polymer Mw
- Best MG available
- High Resolution tools (BMET 0.3 NA, PSI IL)
- Apples-to-Apples comparison (K_{LUP} or Z Parameter)

Break-Through Strategies: An Editorial



Surfaces defined by
Z-Parameter or K_{LUP}

Higher Absorption



Molecular Glass (Pos)



Molecular Glass (Neg)



Higher Quantum Yield



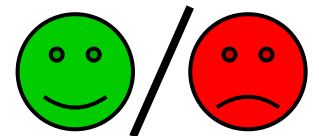
High E_{RED} PAGs



Ultra-High PAG



Anisotropic Diffusion



Acknowledgements

CNSE:

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Peter Trefonas

Kathleen Spear

SEMATECH:

Jacque Georger

Kim Dean

Andrea Wüest

Berkeley:

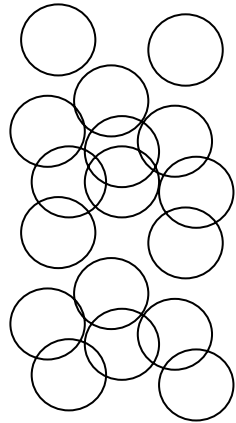
Patrick Naulleau

Chris Anderson

Applied Math Solutions:

Gregg Gallatin

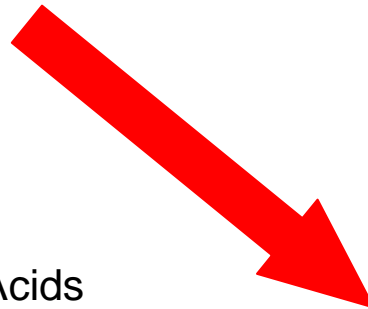
Future Work



We propose that higher quantum yield will allow us to improve resolution, LER...

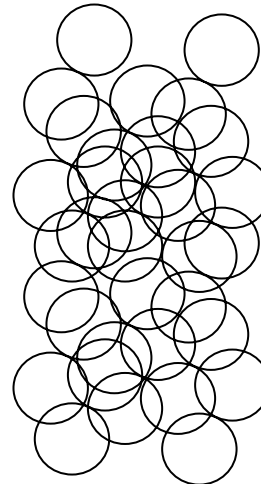


...with no penalty to sensitivity.



This Work

- Increased the # of Acids
- Saturated Sensitivity Improvement
- Used Constant Process

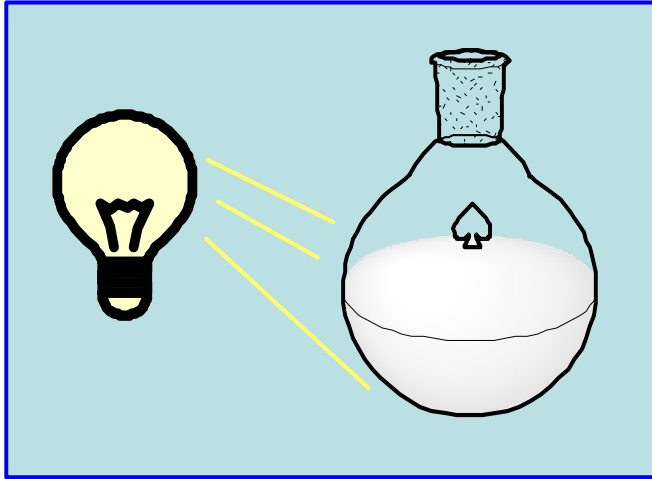


Future Work:

Increased generated acids no longer need to diffuse as far

What is Film Quantum Yield?

Traditional Quantum Yield



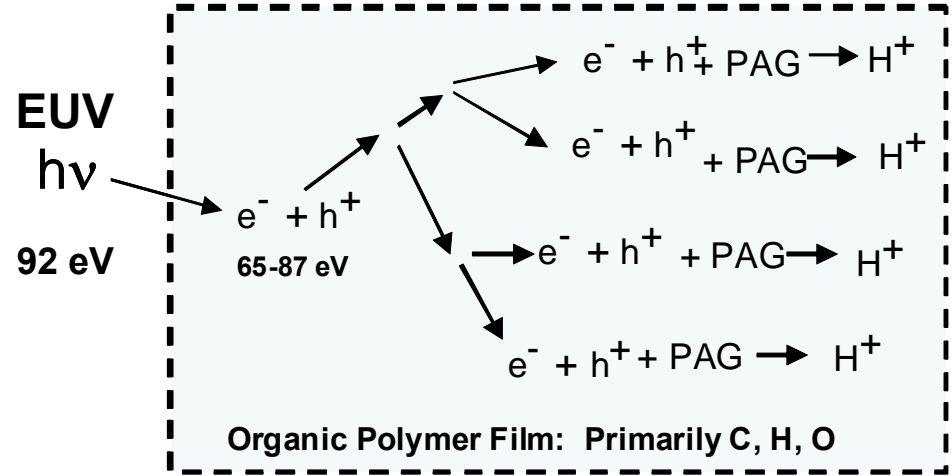
Experiments are done in transparent solvents

Light is primarily absorbed by single molecules

QY < 1

$$\text{Quantum Yield} \equiv \frac{\text{Moles of Product}}{\text{Moles of Photons Absorbed}}$$

vs. Film Quantum Yield



Light is absorbed by everything in the film.

Multiple electrons are made.

FQY of Acid > 1

$$\text{Film Quantum Yield} \equiv \frac{\text{Moles of Acids Generated in the Film}}{\text{Moles of Photons Absorbed by the Film}}$$